RADIO TEST REPORT

Test Report No. : 13015039H

Applicant	:	**TOKAI RIKA CO., LTD.**
Type of Equipment	:	**Smart Key Box**
Model No.	:	**B3R2L2L**
FCC ID	:	**MOZB3R2L2L**
Test regulation	:	**FCC Part 15 Subpart C: 2019**
Test Result	:	**Complied (Refer to SECTION 3.2)**

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
6. The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab.
7. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
8. The information provided from the customer for this report is identified in SECTION 1.

Date of test: October 2 to 7, 2019

Representative test engineer:
Shinya Watanabe
Engineer
Consumer Technology Division

Approved by:
Shinichi Miyazono
Engineer
Consumer Technology Division

NVLAP TESTING NVLAP LAB CODE 200572-0

This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation.
*As for the range of Accreditation in NVLAP, you may refer to the WEB address, http://japan.ul.com/resources/emc_accredited/

☐ The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan.

☒ There is no testing item of "Non-accreditation".

REVISION HISTORY

Original Test Report No.: 13015039H

Revision	Test report No.	Date	Page revised	Contents
- (Original)	13015039H	November 6, 2019	-	-

Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation
AC	Alternating Current
AFH	Adaptive Frequency Hopping
AM	Amplitude Modulation
Amp, AMP	Amplifier
ANSI	American National Standards Institute
Ant, ANT	Antenna
AP	Access Point
ASK	Amplitude Shift Keying
Atten., ATT	Attenuator
AV	Average
BPSK	Binary Phase-Shift Keying
BR	Bluetooth Basic Rate
BT	Bluetooth
BT LE	Bluetooth Low Energy
BW	BandWidth
Cal Int	Calibration Interval
CCK	Complementary Code Keying
Ch., CH	Channel
CISPR	Comite International Special des Perturbations Radioelectriques
CW	Continuous Wave
DBPSK	Differential BPSK
DC	Direct Current
D-factor	Distance factor
DFS	Dynamic Frequency Selection
DQPSK	Differential QPSK
DSSS	Direct Sequence Spread Spectrum
EDR	Enhanced Data Rate
EIRP, e.i.r.p.	Equivalent Isotropically Radiated Power
EMC	ElectroMagnetic Compatibility
EMI	ElectroMagnetic Interference
EN	European Norm
ERP, e.r.p.	Effective Radiated Power
EU	European Union
EUT	Equipment Under Test
Fac.	Factor
FCC	Federal Communications Commission
FHSS	Frequency Hopping Spread Spectrum
FM	Frequency Modulation
Freq.	Frequency
FSK	Frequency Shift Keying
GFSK	Gaussian Frequency-Shift Keying
GNSS	Global Navigation Satellite System
GPS	Global Positioning System
Hori.	Horizontal
ICES	Interference-Causing Equipment Standard
IEC	International Electrotechnical Commission
IEEE	Institute of Electrical and Electronics Engineers
IF	Intermediate Frequency
ILAC	International Laboratory Accreditation Conference
ISED	Innovation, Science and Economic Development Canada
ISO	International Organization for Standardization
JAB	Japan Accreditation Board
LAN	Local Area Network
LIMS	Laboratory Information Management System
MCS	Modulation and Coding Scheme
MRA	Mutual Recognition Arrangement
N/A	Not Applicable
NIST	National Institute of Standards and Technology
NS	No signal detect.
NSA	Normalized Site Attenuation
NVLAP	National Voluntary Laboratory Accreditation Program
OBW	Occupied Band Width
OFDM	Orthogonal Frequency Division Multiplexing
P/M	Power meter
PCB	Printed Circuit Board
PER	Packet Error Rate
PHY	Physical Layer
PK	Peak
PN	Pseudo random Noise
PRBS	Pseudo-Random Bit Sequence
PSD	Power Spectral Density
QAM	Quadrature Amplitude Modulation
QP	Quasi-Peak
QPSK	Quadri-Phase Shift Keying
RBW	Resolution Band Width
RDS	Radio Data System
RE	Radio Equipment
RF	Radio Frequency
RMS	Root Mean Square
RSS	Radio Standards Specifications
Rx	Receiving
SA, S/A	Spectrum Analyzer
SG	Signal Generator
SVSWR	Site-Voltage Standing Wave Ratio
TR	Test Receiver
Tx	Transmitting
VBW	Video BandWidth
Vert.	Vertical
WLAN	Wireless LAN

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SECTION 1: Customer information

Company Name	:	TOKAI RIKA CO., LTD.
Address	:	3-260 Toyota, Oguchi-cho, Niwa-gun, Aichi-ken, 480-0195 Japan
Telephone Number	:	+81-587-95-0093
Facsimile Number	:	+81-587-95-5471
Contact Person	:	Hiroki Unno

The information provided from the customer is as follows;
- Applicant, Type of Equipment, Model No. FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer information
- SECTION 2: Equipment under test (E.U.T.)
- SECTION 4: Operation of E.U.T. during testing

* The laboratory is exempted from liability of any test results affected from the above information in SECTION 2 and 4.

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment	:	Smart Key Box
Model No.	:	B3R2L2L
Serial No.	:	Refer to Section 4, Clause 4.2
Rating	:	DC 12.0 V
Receipt Date of Sample (Information from test lab.)	:	September 11, 2019
Condition of EUT	:	Engineering prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	:	No Modification by the test lab

2.2 Product Description

Model: B3R2L2L (referred to as the EUT in this report) is a Smart Key Box mainly performs the functions in a Smart Key System and a RKE System.

Radio Specification

Radio Type	:	Transceiver
Frequency of Operation	:	Channel1: 314.35 MHz Channel2: 312.10 MHz
Modulation	:	FSK
Antenna Type	:	Pattern Antenna, 3D Antenna
Operating Temperature Range	:	-30 deg. C to +80 deg. C
Operating Voltage Range	:	DC 8 V to 16 V
Clock Frequency (maximum)	:	18.37 MHz
Receiving frequency of Operation	:	125 kHz / 134.2 kHz *1)

*1) The test of receiver part was performed separately from this test report, and the conformability is confirmed.

[Bluetooth Specification]*

Frequency of Operation	:	2402 MHz - 2480 MHz
Type of Modulation	:	GFSK

*The BLE module is a FCC certificated module.

SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C
FCC Part 15 final revised on July 19, 2019 and effective August 19, 2019 except 15.258

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.231 Periodic operation in the band 40.66-40.70 MHz and above 70 MHz.

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted emission	**FCC:** ANSI C63.10:2013 6 Standard test methods **ISED:** RSS-Gen 8.8	**FCC:** Section 15.207 **ISED:** RSS-Gen 8.8	N/A	N/A	*1)
Automatically Deactivate	**FCC:** ANSI C63.10:2013 6 Standard test methods **ISED:** -	**FCC:** Section 15.231(a)(1) **ISED:** RSS-210 A1.1	N/A	Complied a)	Radiated
Electric Field Strength of Fundamental Emission	**FCC:** ANSI C63.10:2013 6 Standard test methods **ISED:** RSS-Gen 6.12	**FCC:** Section 15.231(b) **ISED:** RSS-210 A1.2	1.91 dB 312.100 MHz Vertical PK with Duty Factor	Complied# b)	Radiated
Electric Field Strength of Spurious Emission	**FCC:** ANSI C63.10:2013 6 Standard test methods **ISED:** RSS-Gen 6.13	**FCC:** Section 15.205 Section 15.209 Section 15.231(b) **ISED:** RSS-210 A1.2, 4.4 RSS-Gen 8.9	2.71 dB 2829.150 MHz Horizontal PK with Duty Factor <314.35 MHz>	Complied# b)	Radiated
-20dB Bandwidth	**FCC:** ANSI C63.10:2013 6 Standard test methods **ISED:** -	**FCC:** Section 15.231(c) **ISED:** Reference data	N/A	Complied c)	Radiated

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.
*1) The test is not applicable since the EUT does not have AC Mains.

a) Refer to APPENDIX 1 (data of Automatically deactivate)
b) Refer to APPENDIX 1 (data of Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission))
c) Refer to APPENDIX 1 (data of-20dB and 99% Occupied Bandwidth)

Symbols:
Complied The data of this test item has enough margin, more than the measurement uncertainty.
Complied# The data of this test item meets the limits unless the measurement uncertainty is taken into consideration.

FCC Part 15.31 (e)
This EUT provides stable voltage constantly to RF Module regardless of input voltage. Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement
The antenna is not removable from the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99 % Occupied Bandwidth	**ISED:** RSS-Gen 6.7	**ISED:** RSS-210 A1.3	N/A	-	Radiated
Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.					

3.4 Uncertainty

There is no applicable rule of uncertainty in this applied standard. Therefore, the following results are derived depending on whether or not laboratory uncertainty is applied.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k = 2$.

Radiated emission

Measurement distance	Frequency range		Uncertainty (+/-)
3 m	9 kHz to 30 MHz		3.3 dB
10 m			3.2 dB
3 m	30 MHz to 200 MHz	(Horizontal)	4.8 dB
		(Vertical)	5.0 dB
	200 MHz to 1000 MHz	(Horizontal)	5.2 dB
		(Vertical)	6.3 dB
10 m	30 MHz to 200 MHz	(Horizontal)	4.8 dB
		(Vertical)	4.8 dB
	200 MHz to 1000 MHz	(Horizontal)	5.0 dB
		(Vertical)	5.0 dB
3 m	1 GHz to 6 GHz		4.9 dB
	6 GHz to 18 GHz		5.2 dB
1 m	10 GHz to 26.5 GHz		5.5 dB
	26.5 GHz to 40 GHz		5.5 dB
10 m	1 GHz to 18 GHz		5.2 dB

Antenna Terminal test

Test Item	Uncertainty (+/-)
Automatically Deactivate	0.10 %
-20dB Emission Bandwidth / 99 % Occupied Bandwidth	0.96 %

3.5 Test Location

UL Japan, Inc. Ise EMC Lab.
*NVLAP Lab. code: 200572-0 / FCC Test Firm Registration Number: 199967 / ISED Lab Company Number: 2973C
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN
Telephone: +81 596 24 8999, Facsimile: +81 596 24 8124

Test site	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.5 measurement room	6.4 x 6.4 x 3.0	6.4 x 6.4	-	-
No.6 shielded room	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.11 measurement room	6.2 x 4.7 x 3.0	4.8 x 4.6	-	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0 m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up

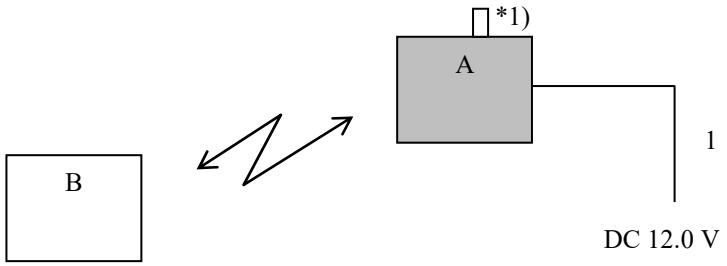
Refer to APPENDIX.

SECTION 4: Operation of E.U.T. during testing

4.1 Operating Mode(s)

Test Item*	Mode
Automatically Deactivate	1) Normal use mode *1)
Electric Field Strength of Fundamental Emission Electric Field Strength of Spurious Emission -20 dB & 99 % Occupied Bandwidth Duty Cycle	2) Transmitting mode (Tx) *2)
* The system was configured in typical fashion (as a user would normally use it) for testing. *1) Once UHF transmission from Smartphone operating *2) Including BLE Communication End users cannot change the settings of the output power of the product.	

4.2 Configuration and peripherals



*1) Toggle switch

* Item B: iPhone was set on the Measurement Room.
* Test data was taken under worse case conditions.

Description of EUT

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Smart Key Box	B3R2L2L	001 *1) 002 *2)	TOKAI RIKA CO., LTD.	EUT
B	iPhone	-	-	Apple	-

*1) Used for Normal use mode
*2) Used for Transmitting mode

List of cables used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	DC Cable	0.75	Unshielded	Unshielded	-

SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission)

Test Procedure and conditions

[For below 30 MHz]
The noise level was checked by moving a search-coil (Loop Antenna) close to the EUT.

[For 30 MHz to 1 GHz]
EUT was placed on a urethane platform of nominal size, 0.5 m by 1.0 m, raised 0.8 m above the conducting ground plane.
The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]
EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane.
The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The measuring antenna height was varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.
Test antenna was aimed at the EUT for receiving the maximum signal and always kept within the illumination area of the 3 dB beamwidth of the antenna.
The measurements were performed for both vertical and horizontal antenna polarization.
The radiated emission measurements were made with the following detector function of the test receiver / spectrum analyzer.

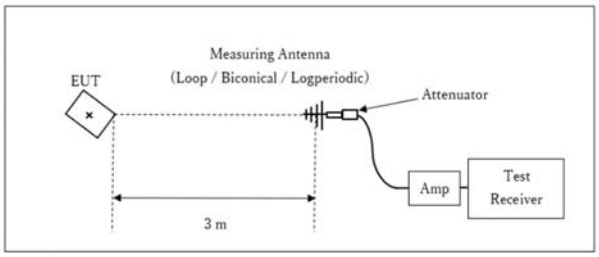
Test Antennas are used as below;

Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

	From 9 kHz to 90 kHz and From 110 kHz to 150 kHz	From 90 kHz to 110 kHz	From 150 kHz to 490 kHz	From 490 kHz to 30 MHz	From 30 MHz to 1 GHz	Above 1 GHz
Detector Type	Peak	Peak	Peak	Peak	Peak and Peak with Duty factor	Peak and Peak with Duty factor
IF Bandwidth	200 Hz	200 Hz	9.0 kHz	9.0 kHz	120 kHz	PK: S/A: RBW 1 MHz, VBW: 3 MHz

[Test Setup]

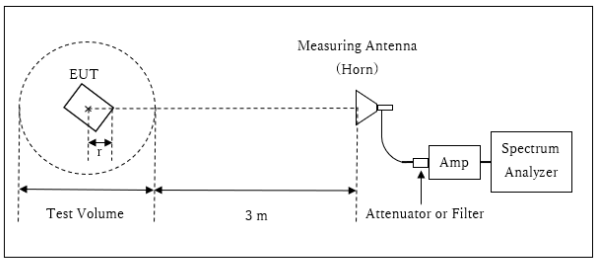
Below 1 GHz



× : Center of turn table

Test Distance: 3 m

1 GHz - 10 GHz



r : Radius of an outer periphery of EUT
× : Center of turn table

Distance Factor: 20 x log (4.0 m / 3.0 m) = 2.5 dB
* Test Distance: (3 + Test Volume /2) - r = 4.0 m

Test Volume : 2.0 m
(Test Volume has been calibrated based on CISPR 16-1-4.)
r = 0.0 m

* The test was performed with r = 0.0 m since EUT is small and it was the rather conservative condition.

- The carrier level (or, noise levels) was (or were) measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined.
Noise levels of all the frequencies were measured at the position.

*The result is rounded off to the second decimal place, so some differences might be observed.

Measurement range : 9 kHz - 3.2 GHz
Test data : APPENDIX
Test result : Pass

SECTION 6: Automatically deactivate

Test Procedure

The measurement was performed with Electric field strength using a spectrum analyzer.

Test data : APPENDIX
Test result : Pass

SECTION 7: -20 dB and 99 % Occupied Bandwidth

Test Procedure

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20 dB Bandwidth	200 kHz	1.5 kHz	5.1 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99 % Occupied Bandwidth	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer
Peak hold was applied as Worst-case measurement.							

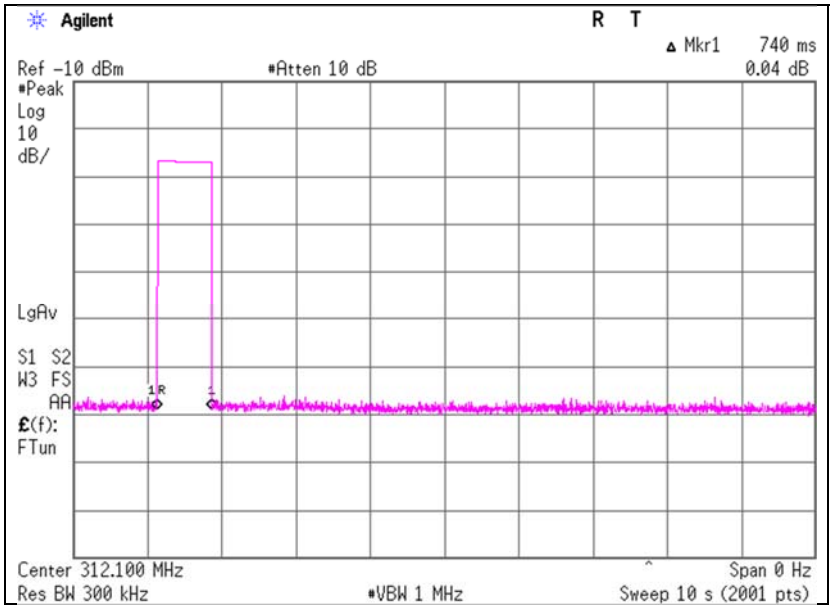
Test data : APPENDIX
Test result : Pass

APPENDIX 1: Test data

Automatically deactivate
312.10 MHz

Report No.	13015039H
Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.1
Date	October 7, 2019
Temperature / Humidity	25 deg. C / 55 % RH
Engineer	Ken Fujita
Mode	Mode 1

Time of Transmitting [sec]	Limit [sec]	Result
0.74	5.00	Pass

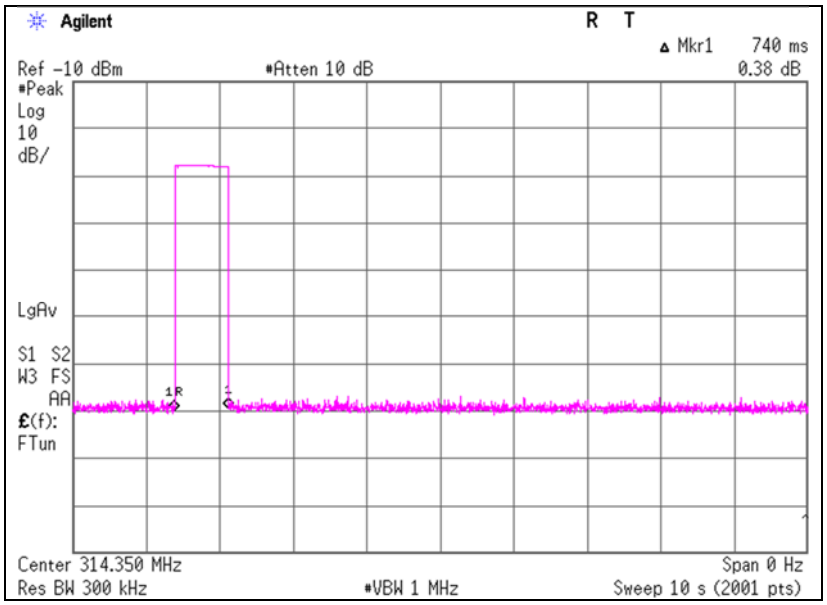


* The test was performed by a request signal (BLE) from Smart phone operation as representative, because the EUT transmits UHF when LF signal is received from a vehicle or a request signal (BLE) from Smart phone is received, and the UHF transmission is stopped within 5 seconds even when receiving LF signal from vehicle.
(Refer to Theory of operation-specification.)

Automatically deactivate
314.35 MHz

Report No.	13015039H
Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.1
Date	October 7, 2019
Temperature / Humidity	25 deg. C / 55 % RH
Engineer	Ken Fujita
Mode	Mode 1

Time of Transmitting [sec]	Limit [sec]	Result
0.74	5.00	Pass



* The test was performed by a request signal (BLE) from Smart phone operation as representative, because the EUT transmits UHF when LF signal is received from a vehicle or a request signal (BLE) from Smart phone is received, and the UHF transmission is stopped within 5 seconds even when receiving LF signal from vehicle.
(Refer to Theory of operation-specification.)

Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

312.10 MHz

Report No.	13015039H	
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.3	No.4
Date	October 02, 2019	October 03, 2019
Temperature / Humidity	20 deg. C / 59 % RH	22 deg. C / 59 % RH
Engineer	Shinya Watanabe (Below 1 GHz)	Akihiko Maeda (Above 1 GHz)
Mode	Mode 2	

PK

Frequency	Detector	Reading [dBuV]		Ant Factor	Loss	Gain	Duty Factor	Result [dBuV/m]		Limit	Margin [dB]		Remark Inside or Outside
[MHz]		Hor	Ver	[dB/m]	[dB]	[dB]	[dB]	Hor	Ver	[dBuV/m]	Hor	Ver	of Restricted Bands
312.100	PK	79.25	81.57	13.79	10.05	31.92	-	71.17	73.49	95.40	24.23	21.91	Carrier
624.200	PK	48.31	46.54	19.46	12.06	31.99	-	47.84	46.07	75.40	27.56	29.33	Outside
936.300	PK	38.82	38.26	22.00	13.69	30.75	-	43.76	43.20	75.40	31.64	32.20	Outside
1248.400	PK	48.50	48.20	25.21	6.32	33.44	-	46.59	46.29	75.40	28.81	29.11	Outside
1560.500	PK	44.80	44.40	24.88	5.77	32.64	-	42.81	42.41	73.90	31.09	31.49	Inside
1872.600	PK	44.90	44.70	25.62	5.77	31.84	-	44.45	44.25	75.40	30.95	31.15	Outside
2184.700	PK	44.50	44.30	28.00	5.86	31.44	-	46.92	46.72	75.40	28.48	28.68	Outside
2496.800	PK	44.30	44.40	27.69	6.00	31.30	-	46.69	46.79	73.90	27.21	27.11	Inside
2808.900	PK	46.80	47.30	28.58	6.08	31.16	-	50.30	50.80	73.90	23.60	23.10	Inside
3121.000	PK	46.70	46.80	28.79	6.19	31.04	-	50.64	50.74	75.40	24.76	24.66	Outside

PK with Duty factor

Frequency	Detector	Reading [dBuV]		Ant Factor	Loss	Gain	Duty Factor	Result [dBuV/m]		Limit	Margin [dB]		Remark
[MHz]		Hor	Ver	[dB/m]	[dB]	[dB]	[dB]	Hor	Ver	[dBuV/m]	Hor	Ver	
312.100	PK	79.25	81.57	13.79	10.05	31.92	0.00	71.17	73.49	75.40	4.23	1.91	Carrier
624.200	PK	48.31	46.54	19.46	12.06	31.99	0.00	47.84	46.07	55.40	7.56	9.33	Outside
936.300	PK	38.82	38.26	22.00	13.69	30.75	0.00	43.76	43.20	55.40	11.64	12.20	Outside
1248.400	PK	48.50	48.20	25.21	6.32	33.44	0.00	46.59	46.29	55.40	8.81	9.11	Outside
1560.500	PK	44.80	44.40	24.88	5.77	32.64	0.00	42.81	42.41	53.90	11.09	11.49	Inside
1872.600	PK	44.90	44.70	25.62	5.77	31.84	0.00	44.45	44.25	55.40	10.95	11.15	Outside
2184.700	PK	44.50	44.30	28.00	5.86	31.44	0.00	46.92	46.72	55.40	8.48	8.68	Outside
2496.800	PK	44.30	44.40	27.69	6.00	31.30	0.00	46.69	46.79	53.90	7.21	7.11	Inside
2808.900	PK	46.80	47.30	28.58	6.08	31.16	0.00	50.30	50.80	53.90	3.60	3.10	Inside
3121.000	PK	46.70	46.80	28.79	6.19	31.04	0.00	50.64	50.74	55.40	4.76	4.66	Outside

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Sample calculation:
Result of PK = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1GHz) +Distance factor (above 1 GHz)} - Gain (Amplifier)
Result of PK with Duty factor = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1 GHz) +Distance factor (above 1 GHz)} - Gain (Amplifier) + Duty factor

For above 1GHz : Distance Factor: 20 x log (4.0 m/3.0 m) = 2.5 dB

Since the peak emission result satisfied the average limit, duty factor was omitted.
Although Duty of this product was 100% or less, the result of AV (PK with Duty factor) was calculated by applying Duty 100% as worst.

Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

314.35 MHz

Report No.	13015039H	
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.3	No.4
Date	October 02, 2019	October 03, 2019
Temperature / Humidity	20 deg. C / 59 % RH	22 deg. C / 59 % RH
Engineer	Shinya Watanabe (Below 1 GHz)	Akihiko Maeda (Above 1 GHz)
Mode	Mode 2	

PK

Frequency	Detector	Reading [dBuV]		Ant Factor	Loss	Gain	Duty Factor	Result [dBuV/m]		Limit	Margin [dB]		Remark Inside or Outside
[MHz]		Hor	Ver	[dB/m]	[dB]	[dB]	[dB]	Hor	Ver	[dBuV/m]	Hor	Ver	of Restricted Bands
314.350	PK	78.60	81.53	13.88	10.06	31.92	-	70.62	73.55	95.50	24.88	21.95	Carrier
628.700	PK	48.70	47.21	19.46	12.08	31.99	-	48.25	46.76	75.50	27.25	28.74	Outside
943.050	PK	38.13	38.34	21.97	13.72	30.71	-	43.11	43.32	75.50	32.39	32.18	Outside
1257.400	PK	48.20	48.50	25.21	6.30	33.41	-	46.30	46.60	75.50	29.20	28.90	Outside
1571.750	PK	42.60	45.30	24.88	5.77	32.61	-	40.64	43.34	73.90	33.26	30.56	Inside
1886.100	PK	45.10	44.90	25.69	5.77	31.81	-	44.75	44.55	75.50	30.75	30.95	Outside
2200.450	PK	43.70	44.00	28.11	5.87	31.43	-	46.25	46.55	73.90	27.65	27.35	Inside
2514.800	PK	44.80	45.00	27.71	6.00	31.29	-	47.22	47.42	75.50	28.28	28.08	Outside
2829.150	PK	47.70	47.40	28.56	6.09	31.16	-	51.19	50.89	73.90	22.71	23.01	Inside
3143.500	PK	46.60	46.60	28.78	6.20	31.03	-	50.55	50.55	75.50	24.95	24.95	Outside

PK with Duty factor

Frequency	Detector	Reading [dBuV]		Ant Factor	Loss	Gain	Duty Factor	Result [dBuV/m]		Limit	Margin [dB]		Remark
[MHz]		Hor	Ver	[dB/m]	[dB]	[dB]	[dB]	Hor	Ver	[dBuV/m]	Hor	Ver	
314.350	PK	78.60	81.53	13.88	10.06	31.92	0.00	70.62	73.55	75.50	4.88	1.95	Carrier
628.700	PK	48.70	47.21	19.46	12.08	31.99	0.00	48.25	46.76	55.50	7.25	8.74	Outside
943.050	PK	38.13	38.34	21.97	13.72	30.71	0.00	43.11	43.32	55.50	12.39	12.18	Outside
1257.400	PK	48.20	48.50	25.21	6.30	33.41	0.00	46.30	46.60	55.50	9.20	8.90	Outside
1571.750	PK	42.60	45.30	24.88	5.77	32.61	0.00	40.64	43.34	53.90	13.26	10.56	Inside
1886.100	PK	45.10	44.90	25.69	5.77	31.81	0.00	44.75	44.55	55.50	10.75	10.95	Outside
2200.450	PK	43.70	44.00	28.11	5.87	31.43	0.00	46.25	46.55	53.90	7.65	7.35	Inside
2514.800	PK	44.80	45.00	27.71	6.00	31.29	0.00	47.22	47.42	55.50	8.28	8.08	Outside
2829.150	PK	47.70	47.40	28.56	6.09	31.16	0.00	51.19	50.89	53.90	2.71	3.01	Inside
3143.500	PK	46.60	46.60	28.78	6.20	31.03	0.00	50.55	50.55	55.50	4.95	4.95	Outside

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

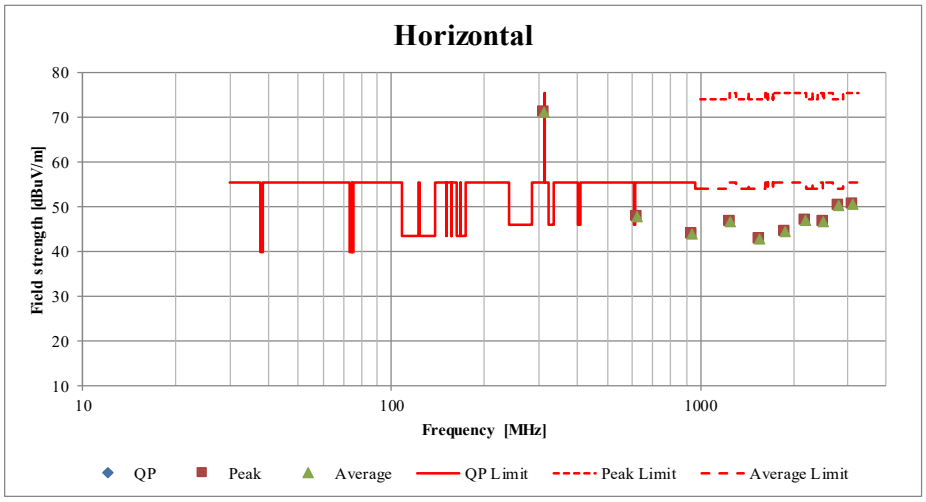
Sample calculation:
Result of PK = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1GHz) +Distance factor (above 1 GHz)} - Gain (Amplifier)
Result of PK with Duty factor = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1 GHz) +Distance factor (above 1 GHz)} - Gain (Amplifier) + Duty factor

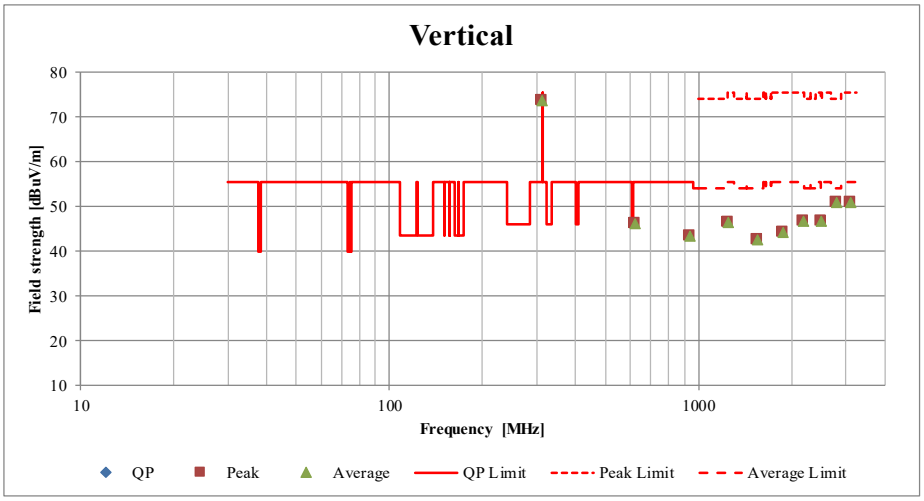
For above 1GHz : Distance Factor: 20 x log (4.0 m/3.0 m) = 2.5 dB

Since the peak emission result satisfied the average limit, duty factor was omitted.
Although Duty of this product was 100% or less, the result of AV (PK with Duty factor) was calculated by applying Duty 100% as worst.

Radiated Spurious Emission
(Plot data, Worst case)

Report No.	13015039H	
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.3	No.4
Date	October 02, 2019	October 03, 2019
Temperature / Humidity	20 deg. C / 59 % RH	22 deg. C / 59 % RH
Engineer	Shinya Watanabe (Below 1 GHz)	Akihiko Maeda (Above 1 GHz)
Mode	Mode 2, Tx 314.35 MHz	





*These plots data contains sufficient number to show the trend of characteristic features for EUT.

-20dB and 99% Occupied Bandwidth

312.10 MHz / 314.35 MHz

Report No.	13015039H
Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.3
Date	October 2, 2019
Temperature / Humidity	20 deg. C / 59 % RH
Engineer	Shinya Watanabe
Mode	Mode 2

Bandwidth Limit : Fundamental Frequency **312.10** MHz x 0.25% = 780.25 kHz

* The above limit was calculated from more stringent nominal frequency.

* Method of KDB 926416 for systems employing non sweeping frequencies was referred.

312.10MHz

-20dB Bandwidth [kHz]
39.626

314.35MHz

-20dB Bandwidth [kHz]
39.587

-20dB Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
79.213	780.25	Pass

Bandwidth Limit : Fundamental Frequency **312.10** MHz x 0.25% = 780.25 kHz

99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
43.0134	780.25	Pass

Bandwidth Limit : Fundamental Frequency **314.35** MHz x 0.25% = 785.88 kHz

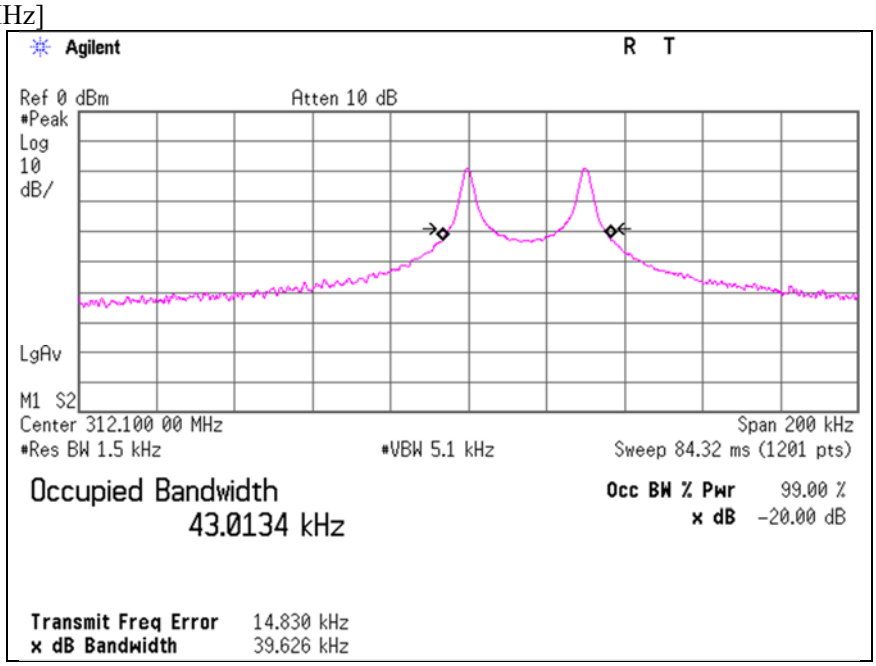
99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
43.0644	785.88	Pass

-20dB and 99% Occupied Bandwidth

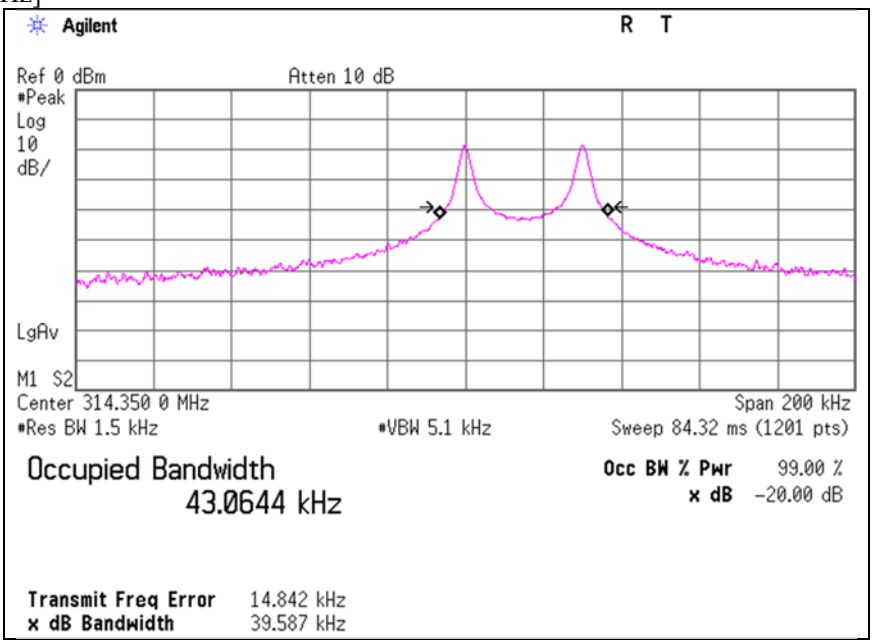
312.10 MHz / 314.35 MHz

Report No.	13015039H
Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.3
Date	October 2, 2019
Temperature / Humidity	20 deg. C / 59 % RH
Engineer	Shinya Watanabe
Mode	Mode 2

[312.10MHz]



[314.35MHz]

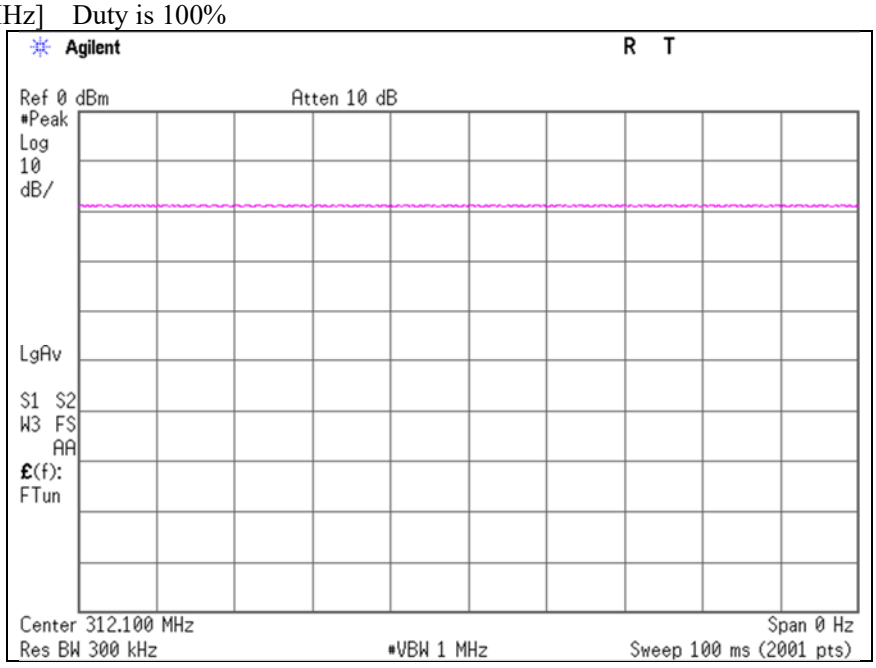


Duty Cycle

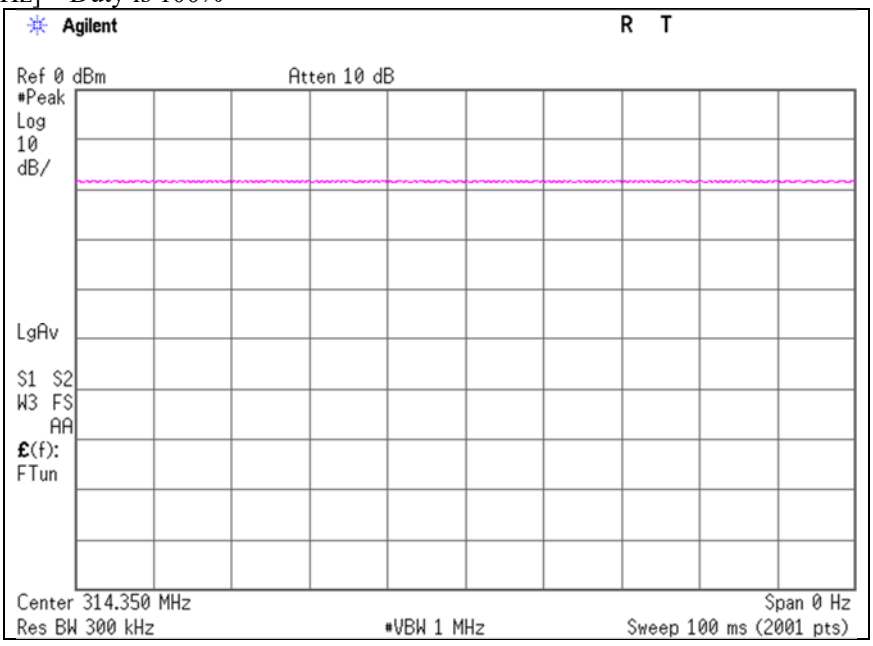
312.10 MHz / 314.35 MHz

Report No.	13015039H
Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.3
Date	October 2, 2019
Temperature / Humidity	20 deg. C / 59 % RH
Engineer	Shinya Watanabe
Mode	Mode 2

[312.10MHz] Duty is 100%



[314.35MHz] Duty is 100%



APPENDIX 2: Test instruments

Test Instruments

Test item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Calibration Due Date	Cal Int
RE	142180	Measure	KOMELON	KMC-36	-	-	-	-
RE	141884	Spectrum Analyzer	AGILENT	E4448A	MY44020357	03/13/2019	03/31/2020	12
RE	141507	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	258	09/26/2019	09/30/2020	12
RE	141266	Logperiodic Antenna(200-1000MHz)	Schwarzbeck	VUSLP9111B	9111B-191	08/24/2019	08/31/2020	12
RE	141424	Biconical Antenna	Schwarzbeck	VHA9103+BBA9106	1915	08/24/2019	08/31/2020	12
RE	141532	DIGITAL HiTESTER	HIOKI	3805	51201197	01/29/2019	01/31/2020	12
RE	142314	Attenuator	Pasternack	PE7390-6	D/C 1504	06/11/2019	06/30/2020	12
RE	141582	Pre Amplifier	SONOMA INSTRUMENT	310	260834	02/08/2019	02/29/2020	12
RE	142008	AC3_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	06/26/2018	06/30/2020	24
RE	141554	Thermo-Hygrometer	CUSTOM	CTH-180	1301	01/11/2019	01/31/2020	12
RE	141152	EMI measurement program	TSJ	TEPTO-DV	-	-	-	-
RE	141942	Test Receiver	Rohde & Schwarz	ESCI	100300	08/08/2019	08/31/2020	12
RE	141297	High Pass Filter(1.1-10GHz)	TOKYO KEIKI	TF219CD1	1001	01/10/2019	01/31/2020	12
RE	141562	Thermo-Hygrometer	CUSTOM	CTH-201	0010	01/11/2019	01/31/2020	12
RE	142011	AC4_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	06/28/2018	06/30/2020	24
RE	141412	Microwave Cable	Junkosha	MWX221	1305S002R(1m) / 1405S146(5m)	06/17/2019	06/30/2020	12
RE	141581	MicroWave System Amplifier	AGILENT	83017A	650	10/04/2018	10/31/2019	12
RE	142017	AC4_Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-10005	04/04/2019	04/30/2021	24
RE	141506	Horn Antenna 15-40GHz	Schwarzbeck	BBHA9170	BBHA9170307	05/10/2019	05/31/2020	12
RE	141508	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	9120D-557	09/26/2019	09/30/2020	12
RE	141545	DIGITAL HiTESTER	HIOKI	3805	51201148	01/29/2019	01/31/2020	12
RE	142227	Measure	KOMELON	KMC-36	-	-	-	-
RE	142645	Loop Antenna	UL Japan	-	-	-	-	-

***Hyphens for Last Calibration Date, Calibration Due Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.**

The expiration date of the calibration is the end of the expired month.
All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test item:
RE: Radiated emission, 99 % Occupied Bandwidth, -20 dB bandwidth, Automatically deactivate and Duty cycle tests